Search Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination	T
10/538,498	ZHANG ET AL.	
Examiner	Art Unit	
Stuart W. Snyder	1648	

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SEARCH NO (INCLUDING SEARCH)
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Dialog: Magnetic, microbead, cell, separat? or isolat?	6/18/2007	sws
EAST: Magnetic, microbead, cell, separat? or isolat?; inventors	6/18/2007	sws